## NP84N075CUE-S12-AZ-VB

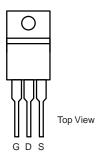


## NP84N075CUE-S12-AZ-VB Datasheet N-Channel 80 V (D-S) MOSFET

PRODUCT SUMMARY			
V <sub>DS</sub>	80	V	
$R_{DS(on)}$ $V_{GS} = 10$ V	7	mΩ	
$R_{DS(on)}$ $V_{GS} = 4.5$ V	9	mΩ	
I <sub>D</sub>	100	А	
Configuration	Single		

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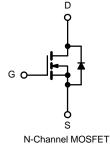


#### FEATURES

- Trench Power MOSFET
- + 100 %  $\rm R_g$  and UIS Tested

#### **APPLICATIONS**

- Primary Side Switching
- Synchronous Rectification
- DC/AC Inverters
- LED Backlighting



ABSOLUTE MAXIMUM RATINGS (	Γ <sub>A</sub> = 25 °C, unless	otherwise no	ted)		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V <sub>DS</sub>	80	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 25 °C		100ª	•	
	T <sub>C</sub> = 70 °C		85 <sup>a</sup>		
	T <sub>A</sub> = 25 °C	I <sub>D</sub>	28.6 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		24.9 <sup>b, c</sup>		
Pulsed Drain Current (t = 100 µs)	I <sub>DM</sub>	350	A		
	T <sub>C</sub> = 25 °C	I <sub>S</sub>	80 <sup>a</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C		4.5 <sup>b, c</sup>		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	30		
Single Pulse Avalanche Energy	L = 0.1 IIIH	E <sub>AS</sub>	45	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		180	W	
	T <sub>C</sub> = 70 °C	P <sub>D</sub>	120		
	T <sub>A</sub> = 25 °C		5 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	]	3.2 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature		260			

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Marian and Institute to Amelian ta	$t \le 10 \text{ sec}$	R <sub>thJA</sub>	15	18	
Maximum Junction-to-Ambient <sup>a</sup>	Steady State	<b>1</b> thJA	40	50	°C/W
Maximum Junction-to-Case		R <sub>thJC</sub>	0.85	1.1	

#### Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.



<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_{D} = 250 \mu A$	80			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	L 050 A		37			
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μΑ		- 6.1		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th</sub> )	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2.0		3.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zere Oete Velte en Drein Ormant		$V_{DS} = 80 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1		
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	85			А	
		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}$		7			
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 6 V, I <sub>D</sub> = 15 A		7.5		mΩ	
		$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 10 \text{ A}$		9			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}$		60		S	
Dynamic <sup>b</sup>	•			•			
Input Capacitance	C <sub>iss</sub>			3855			
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ = 40 V, $V_{GS}$ = 0 V, f = 1 MHz		1120		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			376			
		$V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		35.5			
Total Gate Charge	Qg	$V_{DS} = 40 \text{ V}, V_{GS} = 6 \text{ V}, I_D = 10 \text{ A}$		22			
				18			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 40 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		5.3		nC	
Gate-Drain Charge	Q <sub>gd</sub>			7.3			
Output Charge	Q <sub>oss</sub>	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$		57	86		
Gate Resistance	Rg	f = 1 MHz	0.5	1.3	2	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			12	24		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 40 V, $R_L$ = 4 $\Omega$		8	16		
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong 10 \text{ Å}, V_{\text{GEN}} = 10 \text{ V}, R_g = 1 \Omega$		32	64		
Fall Time	t <sub>f</sub>			7	14		
Turn-On Delay Time	t <sub>d(on)</sub>			14	28	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 40 V, $R_L$ = 4 $\Omega$		11	22		
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong 10 \text{ Å}, V_{GEN} = 6.0 \text{ V}, R_g = 1 \Omega$		30	60		
Fall Time	t <sub>f</sub>			8	16		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			75	^	
Pulse Diode Forward Current (t = 100 $\mu$ s)	I <sub>SM</sub>				150	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A		0.76	1.1	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			38	75	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 10 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		36	70	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ al/at} = 100 \text{ A/} \mu\text{s}, 1\text{ J} = 25 \text{ C}$		19		00	
Reverse Recovery Rise Time	t <sub>b</sub>			19		ns	

#### Notes

a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

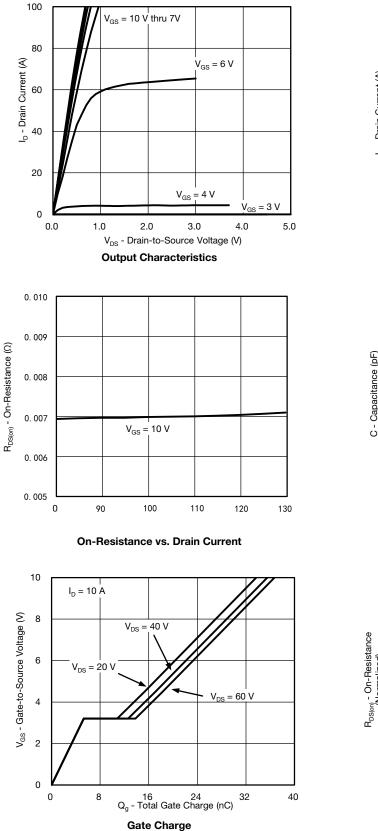
b. Guaranteed by design, not subject to production testing.

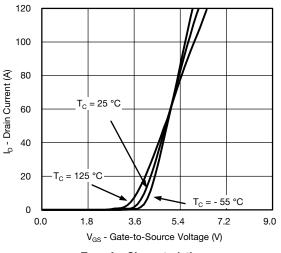
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Bsemi

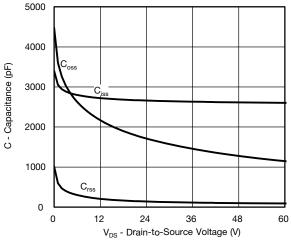
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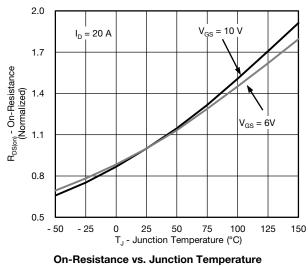




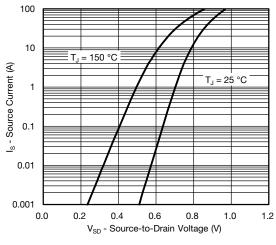
**Transfer Characteristics** 



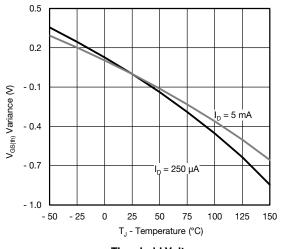




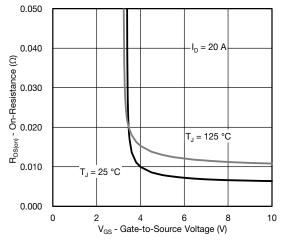




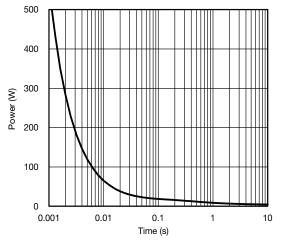
Source-Drain Diode Forward Voltage



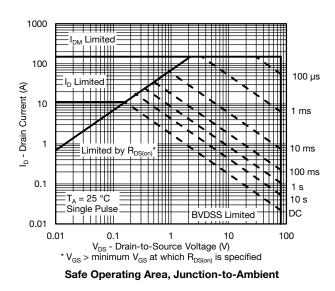




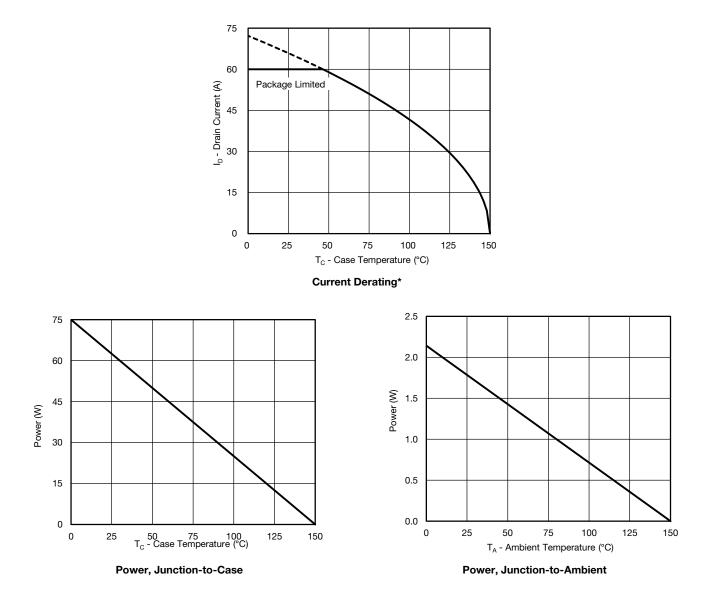
On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

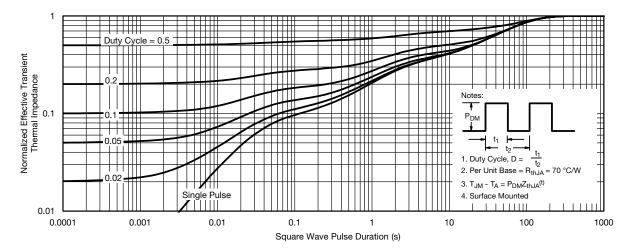




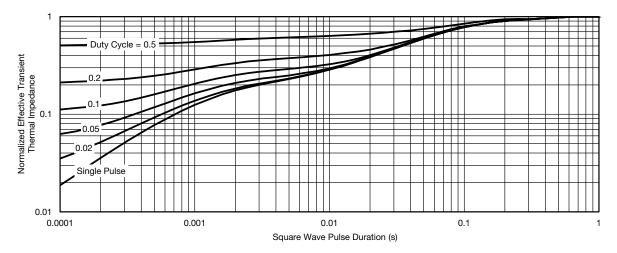


\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





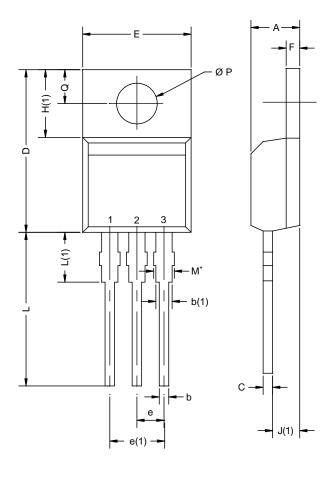
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



## **TO-220AB**



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
Е	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØΡ	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471				

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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